

**Fibre optic communication subsystem test procedures -
Part 2-3: Digital systems - Jitter and wander
measurements**

EESTI STANDARDI EESSÕNA

NATIONAL FOREWORD

Käesolev Eesti standard EVS-EN 61280-2-3:2009 sisaldab Euroopa standardi EN 61280-2-3:2009 ingliskeelset teksti.

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**Fibre optic communication subsystem test procedures -
Part 2-3: Digital systems -
Jitter and wander measurements
(IEC 61280-2-3:2009)**

Procédures d'essai des sous-systèmes
de télécommunications à fibres optiques -
Partie 2-3: Systèmes numériques -
Mesures des giges et des dérapages
(CEI 61280-2-3:2009)

Prüfverfahren für Lichtwellenleiter-
Kommunikationsundersysteme -
Teil: 2-3: Digitale Systeme -
Messung von Jitter und Wander
(IEC 61280-2-3:2009)

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CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: Avenue Marnix 17, B - 1000 Brussels

Foreword

The text of document 86C/885/FDIS, future edition 1 of IEC 61280-2-3, prepared by SC 86C, Fibre optic systems and active devices, of IEC TC 86, Fibre optics, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61280-2-3 on 2009-08-01.

The following dates were fixed:

- | | | |
|--|-------|------------|
| – latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement | (dop) | 2010-05-01 |
| – latest date by which the national standards conflicting with the EN have to be withdrawn | (dow) | 2012-08-01 |

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 61280-2-3:2009 was approved by CENELEC as a European Standard without any modification.

Annex ZA
(normative)

**Normative references to international publications
with their corresponding European publications**

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60825-1	- ¹⁾	Safety of laser products - Part 1: Equipment classification and requirements	EN 60825-1	2007 ²⁾
ITU-T Recommendation G.813	- ¹⁾	Timing characteristics of SDH equipment slave clocks (SEC)	-	-

¹⁾ Undated reference.

²⁾ Valid edition at date of issue.

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FIBRE OPTIC COMMUNICATION SUBSYSTEM TEST PROCEDURES –

Part 2-3: Digital systems – Jitter and wander measurements

1 Scope

This part of IEC 61280 specifies methods for the measurement of the jitter and wander parameters associated with the transmission and handling of digital signals.

1.1 Types of jitter measurements

This standard covers the measurement of the following types of jitter parameters:

- a) jitter tolerance
 - 1) sinusoidal method
 - 2) stressed eye method
- b) jitter transfer function
- c) output jitter
- d) systematic jitter
- e) jitter separation

1.2 Types of wander measurements

This standard covers the measurement of the following types of wander parameters:

- a) non-synchronized wander
- b) TDEV tolerance
- c) TDEV transfer
- d) synchronized wander

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60825-1, *Safety of laser products – Part 1: Equipment classification and requirements*

ITU-T Recommendation G.813, *Timing characteristics of SDH equipment slave clocks (SEC)*

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

NOTE See also IEC 61931.